Ref #	Hits	Search Query	DBs	Default Operator	Plurais	Time Stamp
L2	0	(display adj system) and cpu and memory and branch and column and driver and matrix and (gate adj oxide)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/24 21:10
L3	3	display and cpu and memory and branch and column and driver and matrix and (gate adj oxide)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/24 21:10
L4	1	display and cpu and memory and branch and column and driver and matrix and (gate adj insulator)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/24 21:10
L5	0	display and cpu and memory and branch and column and driver and matrix and (gate adj insulation)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2005/07/24 21:11
S1	2	"20020179969".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:44
S2	2	"2003009465 <u>6</u> ".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:44
S3	2	"20030173570".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45
S4 ,	2	"20040023445".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45

S5	2	"20040051102".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45
S6	1	"20020179969".pn. and (branch or driver)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:44
S7	0	"20030094656".pn. and (branch or driver)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45
S8	1	"20030173570".pn. and (branch or driver)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45
S9	1	"20040023445".pn. and (branch or driver)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45
S10	1	"20040051102".pn. and (branch or driver)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 09:45
S11	39	x adj y adj branch	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 10:37
S13	67	(display adj system) and (cpu or (central adj processing adj unit)) and (column adj driver)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/08 11:26

S14	351	ohtani-hisashi.inv.	US-PGPUB;	OR	ON	2005/06/08 11:26
	331	The state of the s	USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB		,	2555, 55, 55 11.20
S15	0	(first adj gate) near (second adj gate) near thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 14:47
S16	1388	(first adj gate) with (second adj gate) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 14:48
S17	20	different adj gate adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 14:49
S18	279	different adj (gate adj oxide) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 14:50
S19	28	different adj (gate adj insulator) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 14:50
S20	8	different adj (gate adj insulation) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 14:50
S21	2	different adj (gate adj insulating) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2005/07/23 14:50

S22	54	different adj (gate adj dielectric) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:07
S23	7	differing adj (gate adj dielectric) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:10
S24	25	differing adj (gate adj oxide) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:08
S25	3	differing adj (gate adj insulator) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:08
S26	1	differing adj (gate adj insulation) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:08
S27	0	differing adj (gate adj insulating) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:08
S28	0	differing adj (gate adj insulative) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:08
S29		varying adj (gate adj dielectric) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:10

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S30	25	varying adj (gate adj oxide) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:14
S31		varying adj (gate adj insulator) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:11
S32	0	varying adj (gate adj insulation) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:11
S33	0	varying adj (gate adj insulating) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:11
S34	0	varying adj (gate adj insulative) adj thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:11
S35	29	(first adj gate adj oxide) with smaller with (second adj gate adj oxide) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:18
S36		(first adj gate adj dielectric) with smaller with (second adj gate adj dielectric) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2005/07/23 15:39
S37	8	(first adj gate adj dielectric) with thinner with (second adj gate adj dielectric) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:16

S38	2	(first adj gate adj dielectric) with thicker with (second adj gate adj dielectric) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:17
S39	1	(first adj gate adj dielectric) with larger with (second adj gate adj dielectric) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:17
S40	19	(first adj gate adj oxide) with larger with (second adj gate adj oxide) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON .	2005/07/23 15:19
S41	40	(first adj gate adj oxide) with thinner with (second adj gate adj oxide) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:22
S42		(first adj gate adj oxide) with thicker with (second adj gate adj oxide) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2005/07/23 15:25
S43	9	(first adj gate adj insulator) with thicker with (second adj gate adj insulator) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:29
S44	. 11	(first adj gate adj insulation) with thicker with (second adj gate adj insulation) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:30
S45	34	(first adj gate adj insulating) with thicker with (second adj gate adj insulating) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:32

S46	0	(first adj gate adj insulative) with thicker with (second adj gate adj insulative) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:33
S47	0	(first adj gate adj insulative) with smaller with (second adj gate adj insulative) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:33
S48	. 40	(first adj gate adj insulating) with smaller with (second adj gate adj insulating) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:37
S49	7	(first adj gate adj insulation) with smaller with (second adj gate adj insulation) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:37
S50	3	(first adj gate adj insulator) with smaller with (second adj gate adj insulator) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:38
S51	735	(first adj gate) with (second adj gate) with width	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:40
S52	244	different adj gate adj width	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:46
S53	8	differing adj gate adj width	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:46

S54	71	varying adj gate adj width	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:56
S55	3	"20030042559".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:57
S56	3	"20050040476".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON .	2005/07/23 15:57
S57	2	"5292675".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:58
S58	2	"5306651".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:58
S59	. 2	"5468987".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:58
S60	3	"5719065".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON·	2005/07/23 15:59
S61	4	"5879969".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:59

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S62	4	"5917225".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 16:00
S63	3	"5945711".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 15:59
S64	3	"6335555".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 16:00
S65	3	"6835607".pn.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/23 16:00